



flowBOOST 0 dual SiC

1200 V / 75 mΩ

Topology features

- Kelvin Emitter for improved switching performance
- Dual Booster
- Bypass Diode
- Open Emitter configuration
- Temperature sensor

Component features

- High Blocking Voltage with low drain source on state resistance
- High speed SiC-MOSFET technology
- Resistant to Latch-up

Housing features

- Base isolation: Al₂O₃
- Clip-in, reliable mechanical connection, qualified for wave soldering
- Convex shaped substrate for superior thermal contact
- Thermo-mechanical push-and-pull force relief
- Press-fit pin
- Reliable cold welding connection

Target applications

- Solar Inverters

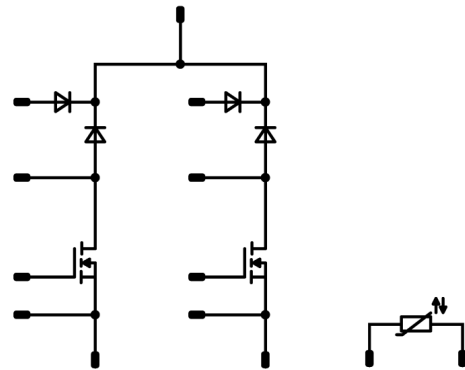
Types

- 10-PZ12B2A075ME-P621L18Y

flow 0 12 mm housing



Schematic





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10-PZ12B2A075ME-P621L18Y
datasheet

Maximum Ratings

$T_j = 25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Boost Switch				
Drain-source voltage	V_{DSS}		1200	V
Drain current (DC current)	I_D	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	20	A
Peak drain current	I_{DM}	t_p limited by T_{jmax}	80	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	52	W
Gate-source voltage	V_{GSS}		-4 / 15	V
		dynamic	-8 / 19	
Maximum Junction Temperature	T_{jmax}		175	°C

Boost Diode

Peak repetitive reverse voltage	V_{RRM}		1200	V
Forward current (DC current)	I_F	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	19	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}	52	A
Surge (non-repetitive) forward current	I_{FSM}	Single Half Sine Wave, $t_p = 10\text{ ms}$ $T_j = 25\text{ °C}$	92	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	58	W
Maximum junction temperature	T_{jmax}		175	°C

ByPass Diode

Peak repetitive reverse voltage	V_{RRM}		1600	V
Forward current (DC current)	I_F	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	38	A
Surge (non-repetitive) forward current	I_{FSM}	Single Half Sine Wave, $t_p = 10\text{ ms}$ $T_j = 150\text{ °C}$	270	A
Surge current capability	I^2t		370	A ² s
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	47	W
Maximum junction temperature	T_{jmax}		150	°C



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datasheet

Maximum Ratings

$T_j = 25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
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Module Properties

Thermal Properties

Storage temperature	T_{stg}		-40...+125	°C
Operation temperature under switching condition	T_{jop}		-40...+($T_{jmax} - 25$)	°C

Isolation Properties

Isolation voltage	V_{isol}	DC Test Voltage* $t_p = 2\text{ s}$	6000	V
Isolation voltage	V_{isol}	AC Voltage $t_p = 1\text{ min}$	2500	V
Creepage distance			min 12,7	mm
Clearance			9,15	mm
Comparative Tracking Index	CTI		≥ 200	

*100 % tested in production



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Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
		V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max		

Boost Switch

Static

Drain-source on-state resistance	$r_{DS(on)}$	15		20	25 125 150		76,2 105 116	90 ⁽¹⁾	mΩ
Gate-source threshold voltage	$V_{GS(th)}$	0		0,005	25	1,7	2,5	4	V
Gate to Source Leakage Current	I_{GSS}	15	0		25		10	250	nA
Zero Gate Voltage Drain Current	I_{DSS}	0	1200		25		1	100	μA
Internal gate resistance	r_g						10,5		Ω
Gate charge	Q_g	-4/15	800	20	25		54		nC
Short-circuit input capacitance	C_{iss}	$f = 1$ Mhz	0	1000	0	25	1350		pF
Short-circuit output capacitance	C_{oss}						58		
Reverse transfer capacitance	C_{rss}						3		
Diode forward voltage	V_{SD}	0		10	25		4,5		V

Thermal

Thermal resistance junction to sink ⁽²⁾	$R_{th(j-s)}$	$\lambda_{paste} = 3,4$ W/mK (PSX)					1,84		K/W
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Dynamic

Turn-on delay time	$t_{d(on)}$	$R_{gon} = 8$ Ω $R_{goff} = 8$ Ω	0/15	700	16	25	14,4		ns
Rise time	t_r					125	12,8		
						150	12,48		
						25	9,28		
Turn-off delay time	$t_{d(off)}$					125	9,28		
						150	8,96		
						25	69,76		
Fall time	t_f	125	78,4						
		150	80,96						
		25	27,91						
Turn-on energy (per pulse)	E_{on}	125	30,9						
		150	32,13						
		25	0,235						
Turn-off energy (per pulse)	E_{off}	125	0,216						
		150	0,212						
		25	0,08						
		125	0,087						
		150	0,091						



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datasheet

Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
		V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max		
Boost Diode										
Static										
Forward voltage	V_F			10	25 125 150		1,43 1,73 1,84	1,8 ⁽¹⁾		V
Reverse leakage current	I_R	$V_r = 1200$ V			25		40	300		μA
Thermal										
Thermal resistance junction to sink ⁽²⁾	$R_{th(j-s)}$	$\lambda_{paste} = 3,4$ W/mK (PSX)					1,64			K/W
Dynamic										
Peak recovery current	I_{RRM}				25 125 150		7,75 8,71 8,88			A
Reverse recovery time	t_{rr}				25 125 150		26,16 24,28 23,87			ns
Recovered charge	Q_r	$di/dt=2071$ A/μs $di/dt=2263$ A/μs $di/dt=2290$ A/μs	0/15	700	16	25 125 150	0,119 0,113 0,111			μC
Reverse recovered energy	E_{rec}				25 125 150		0,047 0,044 0,043			mWs
Peak rate of fall of recovery current	$(di_r/dt)_{max}$				25 125 150		733,99 1159 1267			A/μs



Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
		V_{GS} [V]	V_{GE} [V]	V_{DS} [V]	V_{CE} [V]	T_j [°C]	Min	Typ	Max	

ByPass Diode

Static

Forward voltage	V_F				28	25 125		1,15 1,1	1,5 ⁽¹⁾	V
Reverse leakage current	I_R	$V_i = 1600$ V				25 150			100 1000	μA

Thermal

Thermal resistance junction to sink ⁽²⁾	$R_{th(j-s)}$	$\lambda_{paste} = 3,4$ W/mK (PSX)						1,5		K/W
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Thermistor

Static

Rated resistance	R					25		22		kΩ
Deviation of R_{100}	$\Delta_{R/R}$	$R_{100} = 1484$ Ω				100	-5		5	%
Power dissipation	P					25		130		mW
Power dissipation constant	d					25		1,5		mW/K
B-value	$B_{(25/50)}$	Tol. ±1 %						3962		K
B-value	$B_{(25/100)}$	Tol. ±1 %						4000		K
Vincotech Thermistor Reference									I	

⁽¹⁾ Value at chip level

⁽²⁾ Only valid with pre-applied Vincotech thermal interface material.



Boost Switch Characteristics

figure 1. MOSFET

Typical output characteristics

$$I_D = f(V_{DS})$$

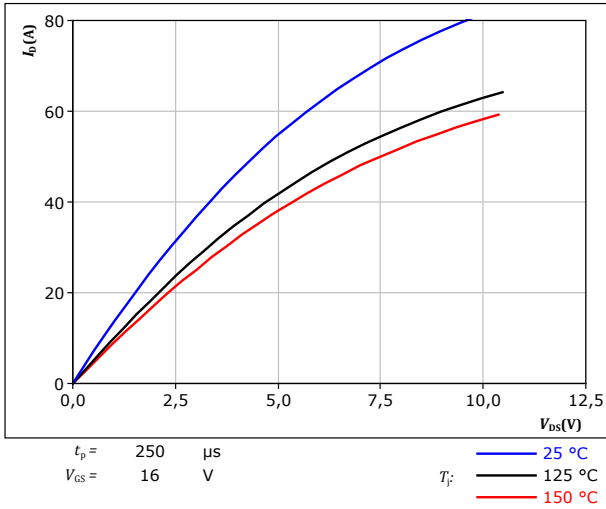


figure 2. MOSFET

Typical output characteristics

$$I_D = f(V_{DS})$$

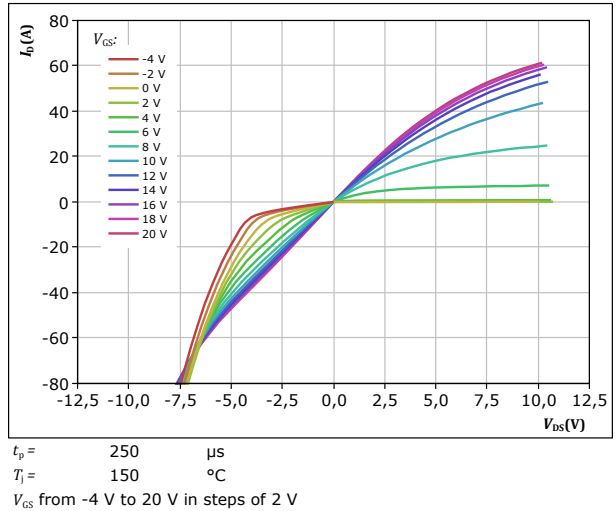


figure 3. MOSFET

Typical transfer characteristics

$$I_D = f(V_{GS})$$

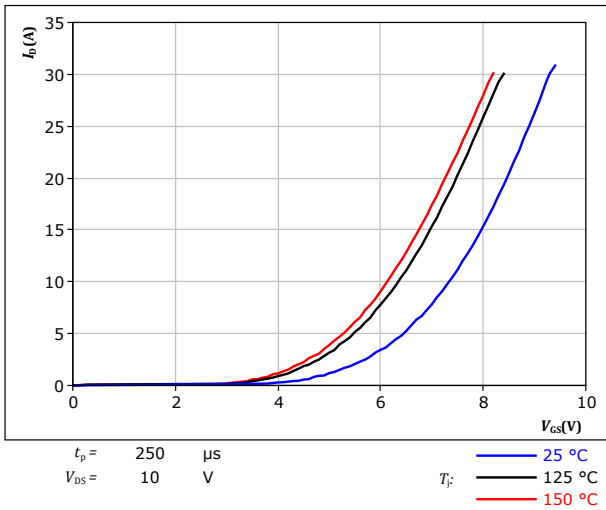
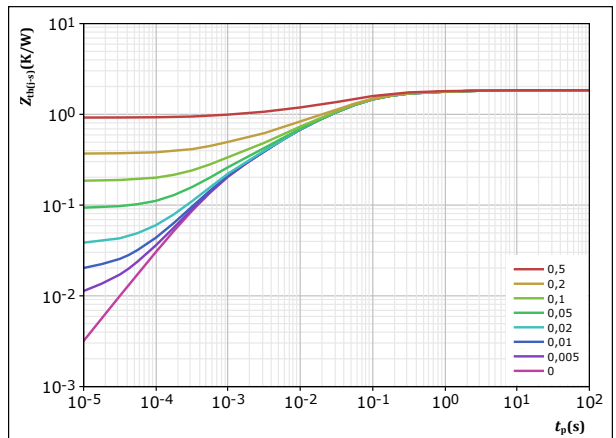


figure 4. MOSFET

Transient thermal impedance as a function of pulse width

$$Z_{th(j-s)} = f(t_p)$$



$D = t_p / T$
 $R_{th(j-s)} = 1,843 \text{ K/W}$

MOSFET thermal model values

R (K/W)	τ (s)
1,10E-01	1,89E+00
4,15E-01	1,55E-01
7,53E-01	3,96E-02
4,02E-01	6,20E-03
1,64E-01	7,03E-04

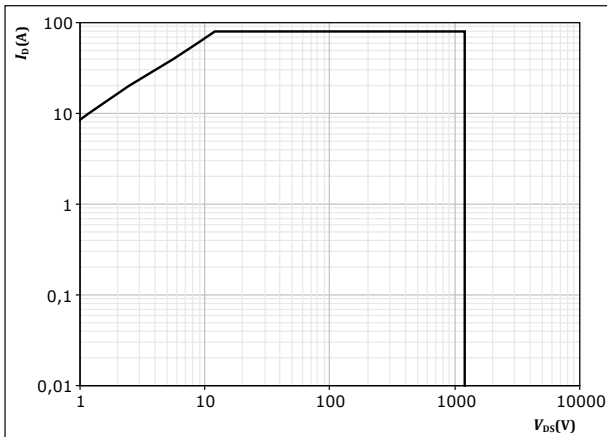


Boost Switch Characteristics

figure 5. MOSFET

Safe operating area

$$I_D = f(V_{DS})$$



$D =$ single pulse
 $T_s = 80 \text{ } ^\circ\text{C}$
 $V_{GS} = 16 \text{ V}$
 $T_j = T_{jmax}$



Boost Diode Characteristics

figure 6. FWD

Typical forward characteristics

$$I_F = f(V_F)$$

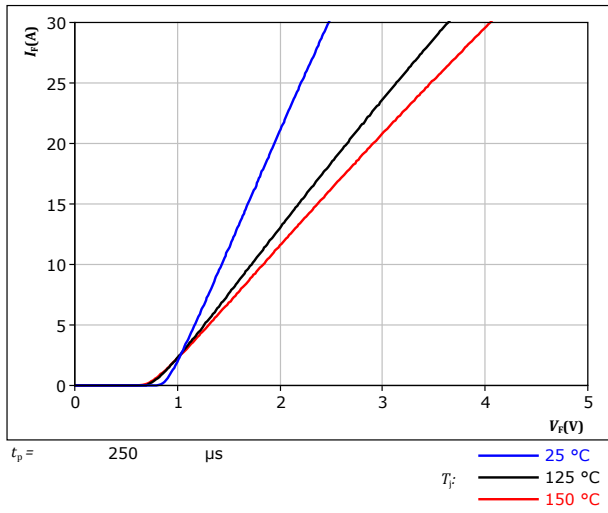
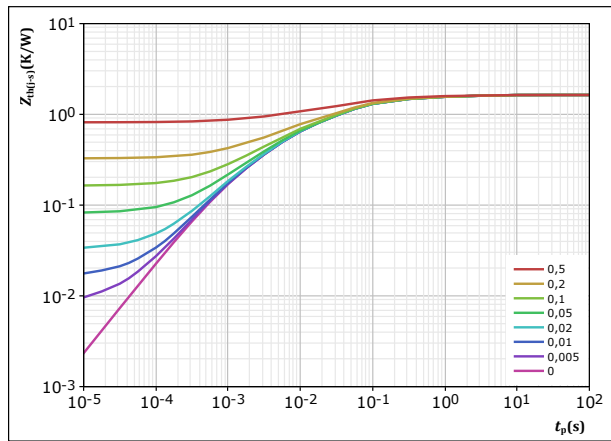


figure 7. FWD

Transient thermal impedance as a function of pulse width

$$Z_{th(j-s)} = f(t_p)$$



$D =$	t_p / T	
$R_{th(j-s)} =$	1,635	K/W
FWD thermal model values		
R (K/W)	τ (s)	
1,05E-01	2,56E+00	
2,66E-01	2,22E-01	
7,28E-01	4,00E-02	
4,30E-01	5,14E-03	
1,07E-01	8,14E-04	



ByPass Diode Characteristics

figure 8. Rectifier

Typical forward characteristics

$$I_F = f(V_F)$$

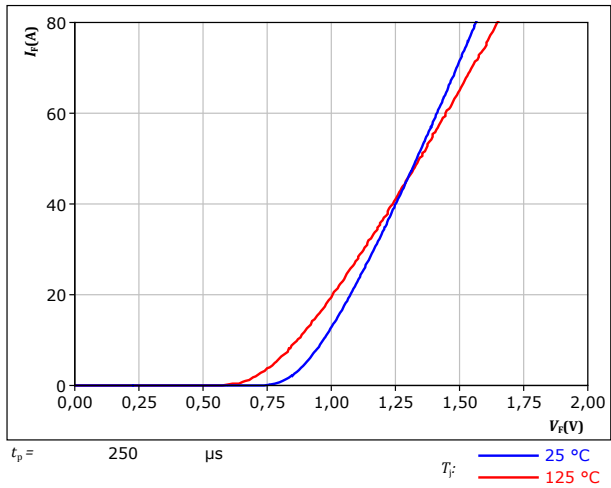
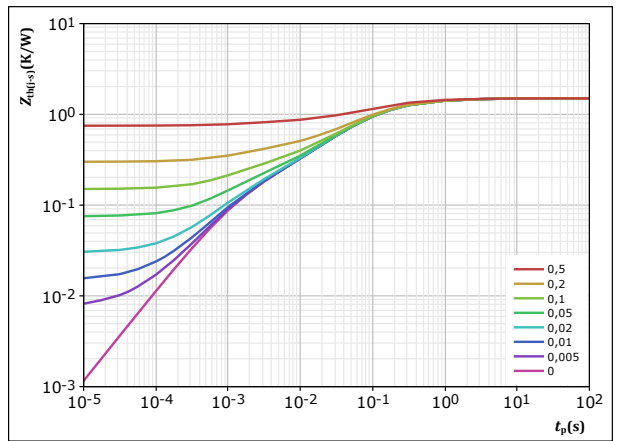


figure 9. Rectifier

Transient thermal impedance as a function of pulse width

$$Z_{th(j-s)} = f(t_p)$$



$D = \frac{t_p}{T}$
 $R_{th(j-s)} = 1,5 \text{ K/W}$
 Rectifier thermal model values

R (K/W)	τ (s)
9,44E-02	2,48E+00
3,47E-01	3,51E-01
7,44E-01	7,63E-02
2,04E-01	1,21E-02
1,11E-01	1,25E-03

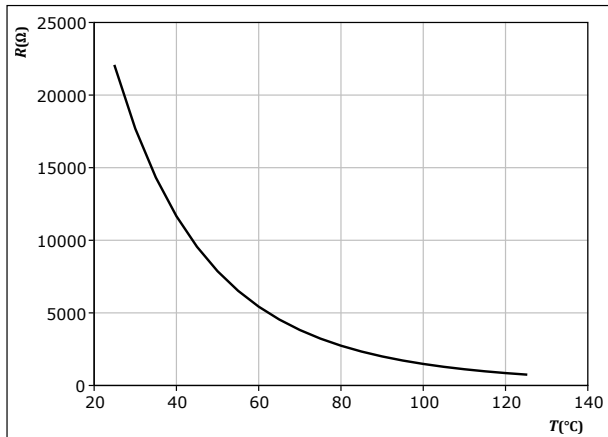


Thermistor Characteristics

figure 10. Thermistor

Typical NTC characteristic as function of temperature

$$R_T = f(T)$$

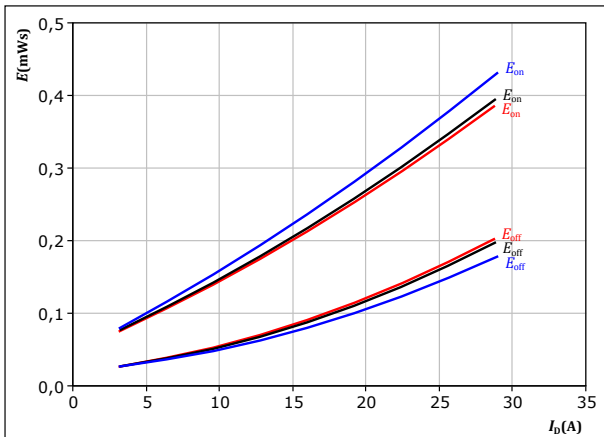




Boost Switching Characteristics

figure 11. MOSFET

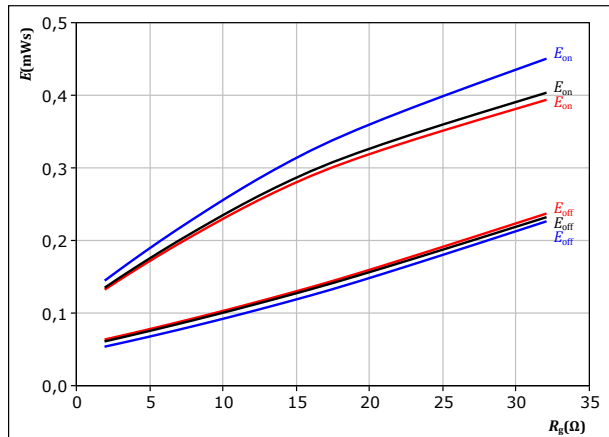
Typical switching energy losses as a function of drain current
 $E = f(I_D)$



With an inductive load at
 $V_{DS} = 700 \text{ V}$
 $V_{GS} = 0/15 \text{ V}$
 $R_{gon} = 8 \ \Omega$
 $R_{goff} = 8 \ \Omega$
 $T_j: 25 \text{ °C}$
 125 °C
 150 °C

figure 12. MOSFET

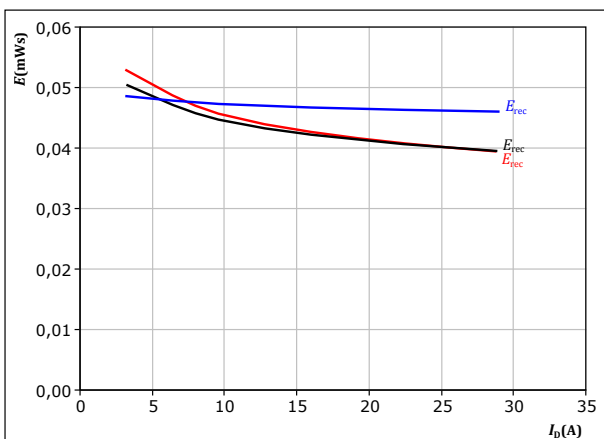
Typical switching energy losses as a function of MOSFET turn on gate resistor
 $E = f(R_g)$



With an inductive load at
 $V_{DS} = 700 \text{ V}$
 $V_{GS} = 0/15 \text{ V}$
 $I_D = 16 \text{ A}$
 $T_j: 25 \text{ °C}$
 125 °C
 150 °C

figure 13. FWD

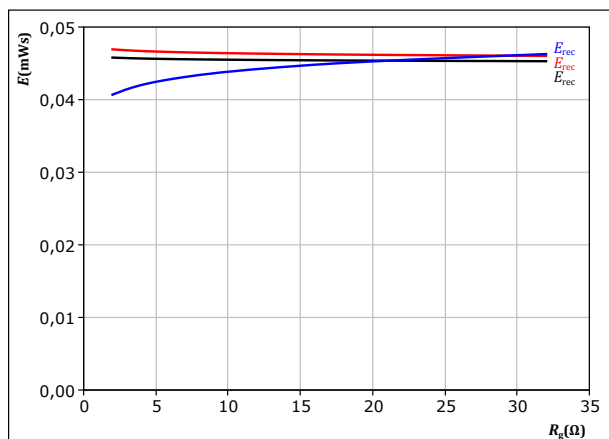
Typical reverse recovered energy loss as a function of drain current
 $E_{rec} = f(I_D)$



With an inductive load at
 $V_{DS} = 700 \text{ V}$
 $V_{GS} = 0/15 \text{ V}$
 $R_{gon} = 8 \ \Omega$
 $T_j: 25 \text{ °C}$
 125 °C
 150 °C

figure 14. FWD

Typical reverse recovered energy loss as a function of MOSFET turn on gate resistor
 $E_{rec} = f(R_g)$



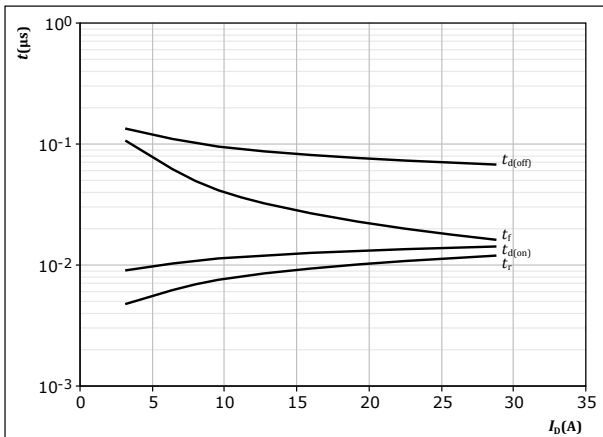
With an inductive load at
 $V_{DS} = 700 \text{ V}$
 $V_{GS} = 0/15 \text{ V}$
 $I_D = 16 \text{ A}$
 $T_j: 25 \text{ °C}$
 125 °C
 150 °C



Boost Switching Characteristics

figure 15. MOSFET

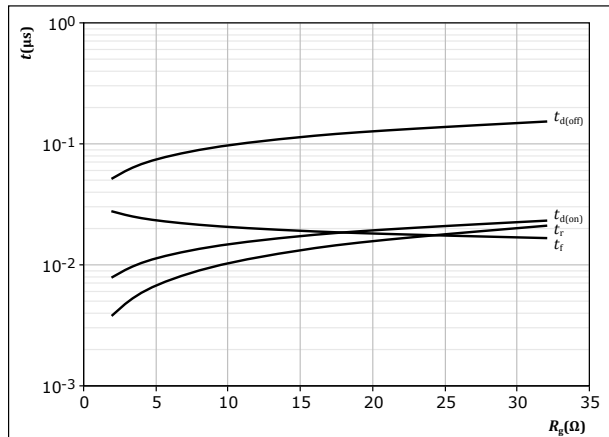
Typical switching times as a function of drain current
 $t = f(I_D)$



With an inductive load at
 $T_j = 150 \text{ }^\circ\text{C}$
 $V_{DS} = 700 \text{ V}$
 $V_{GS} = 0/15 \text{ V}$
 $R_{gon} = 8 \text{ } \Omega$
 $R_{goff} = 8 \text{ } \Omega$

figure 16. MOSFET

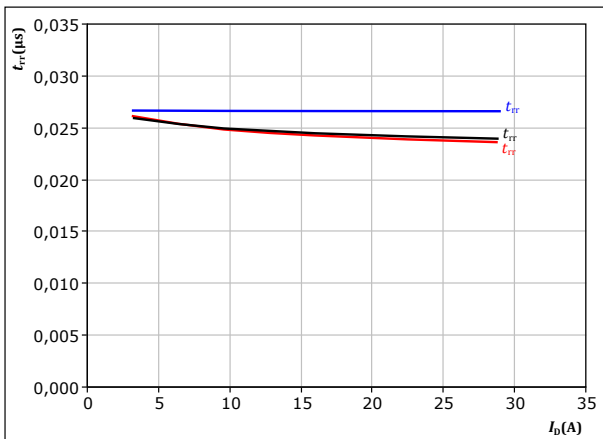
Typical switching times as a function of MOSFET turn on gate resistor
 $t = f(R_g)$



With an inductive load at
 $T_j = 150 \text{ }^\circ\text{C}$
 $V_{DS} = 700 \text{ V}$
 $V_{GS} = 0/15 \text{ V}$
 $I_D = 16 \text{ A}$

figure 17. FWD

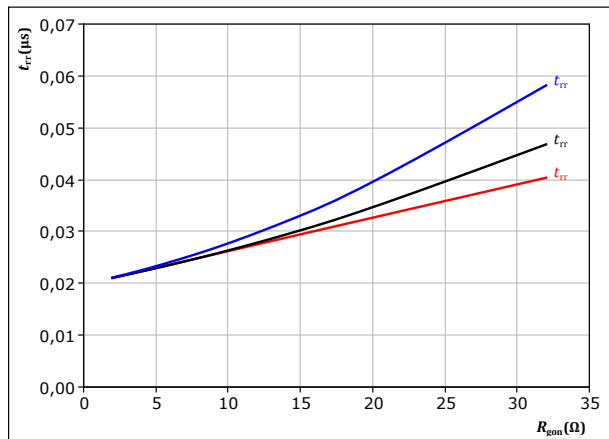
Typical reverse recovery time as a function of drain current
 $t_{rr} = f(I_D)$



At $V_{DS} = 700 \text{ V}$
 $V_{GS} = 0/15 \text{ V}$
 $R_{gon} = 8 \text{ } \Omega$
 $T_j: 25 \text{ }^\circ\text{C}$
 $125 \text{ }^\circ\text{C}$
 $150 \text{ }^\circ\text{C}$

figure 18. FWD

Typical reverse recovery time as a function of MOSFET turn on gate resistor
 $t_{rr} = f(R_{gon})$



At $V_{DS} = 700 \text{ V}$
 $V_{GS} = 0/15 \text{ V}$
 $I_D = 16 \text{ A}$
 $T_j: 25 \text{ }^\circ\text{C}$
 $125 \text{ }^\circ\text{C}$
 $150 \text{ }^\circ\text{C}$

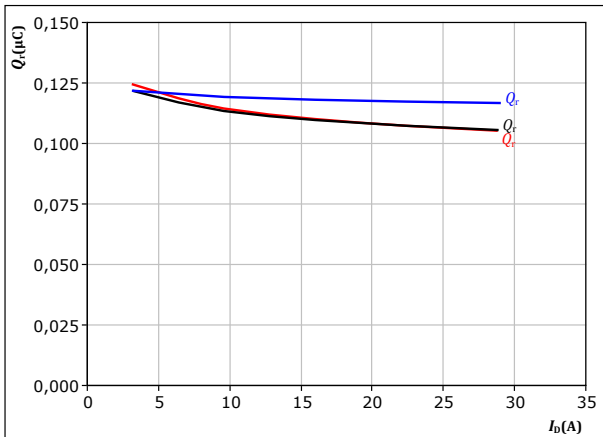


Boost Switching Characteristics

figure 19. FWD

Typical recovered charge as a function of drain current

$$Q_r = f(I_D)$$



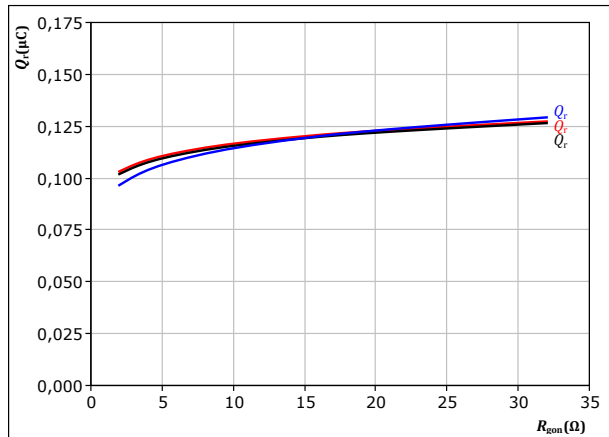
At $V_{DS} = 700$ V
 $V_{GS} = 0/15$ V
 $R_{gon} = 8$ Ω

T_j : — 25 °C
 — 125 °C
 — 150 °C

figure 20. FWD

Typical recovered charge as a function of MOSFET turn on gate resistor

$$Q_r = f(R_{gon})$$



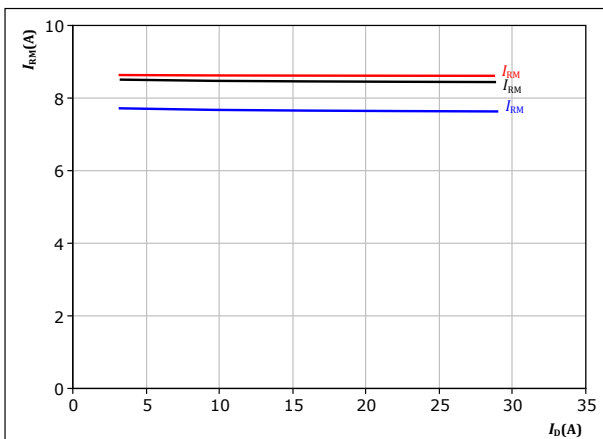
At $V_{DS} = 700$ V
 $V_{GS} = 0/15$ V
 $I_D = 16$ A

T_j : — 25 °C
 — 125 °C
 — 150 °C

figure 21. FWD

Typical peak reverse recovery current as a function of drain current

$$I_{RM} = f(I_D)$$



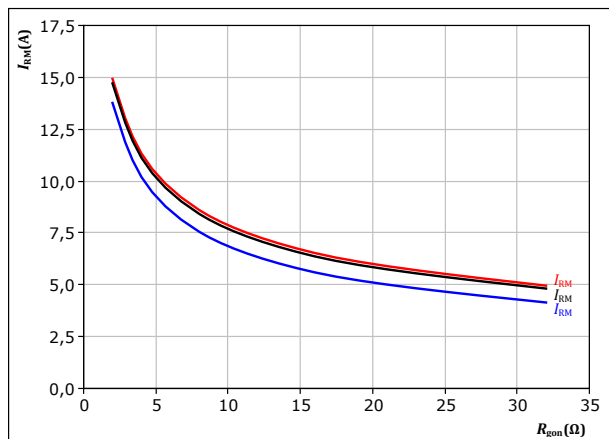
At $V_{DS} = 700$ V
 $V_{GS} = 0/15$ V
 $R_{gon} = 8$ Ω

T_j : — 25 °C
 — 125 °C
 — 150 °C

figure 22. FWD

Typical peak reverse recovery current as a function of MOSFET turn on gate resistor

$$I_{RM} = f(R_{gon})$$



At $V_{DS} = 700$ V
 $V_{GS} = 0/15$ V
 $I_D = 16$ A

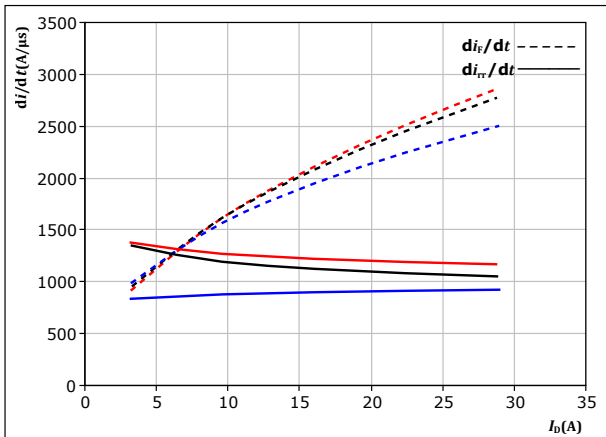
T_j : — 25 °C
 — 125 °C
 — 150 °C



Boost Switching Characteristics

figure 23. FWD

Typical rate of fall of forward and reverse recovery current as a function of drain current
 $di_f/dt, di_{rr}/dt = f(I_D)$

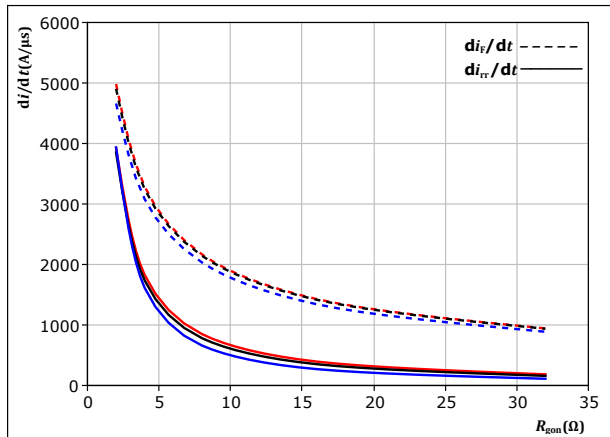


At $V_{DS} = 700$ V
 $V_{GS} = 0/15$ V
 $R_{g(on)} = 8$ Ω

$T_j = 25$ °C
 125 °C
 150 °C

figure 24. FWD

Typical rate of fall of forward and reverse recovery current as a function of turn on gate resistor
 $di_f/dt, di_{rr}/dt = f(R_{g(on)})$

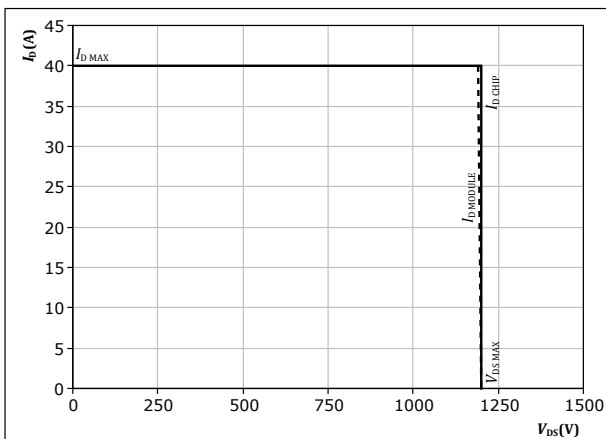


At $V_{DS} = 700$ V
 $V_{GS} = 0/15$ V
 $I_D = 16$ A

$T_j = 25$ °C
 125 °C
 150 °C

figure 25. MOSFET

Reverse bias safe operating area
 $I_D = f(V_{DS})$



At $T_j = 150$ °C
 $R_{g(on)} = 8$ Ω
 $R_{g(off)} = 8$ Ω



Boost Switching Definitions

figure 26. MOSFET

Turn-off Switching Waveforms & definition of t_{doff} t_{Eoff} (t_{Eoff} = integrating time for E_{off})

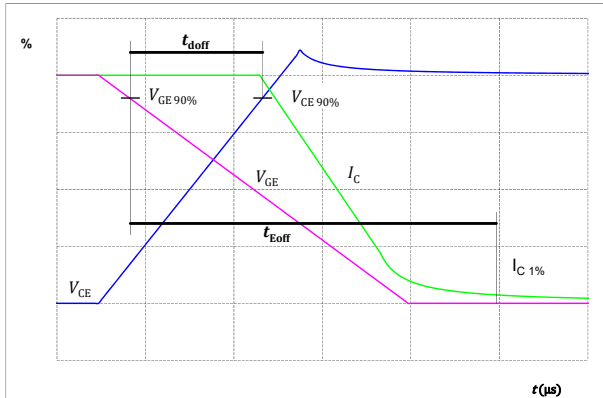


figure 27. MOSFET

Turn-on Switching Waveforms & definition of t_{don} t_{Eon} (t_{Eon} = integrating time for E_{on})

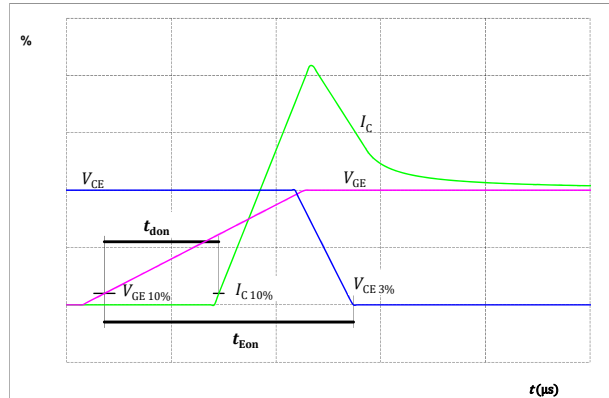


figure 28. MOSFET

Turn-off Switching Waveforms & definition of t_f

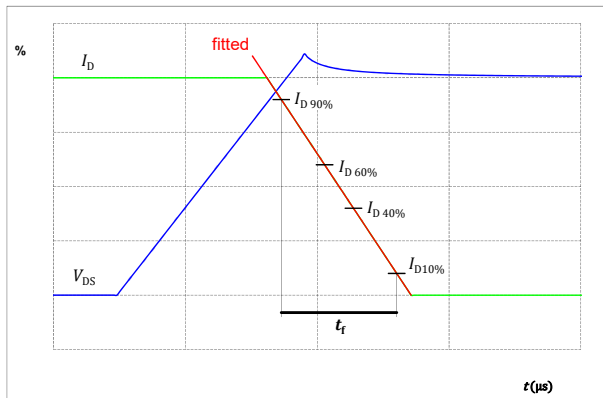
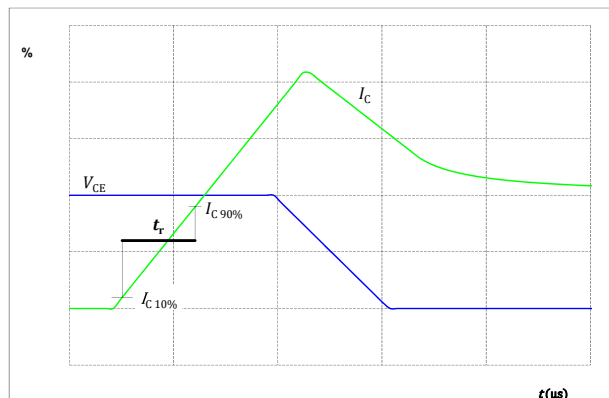


figure 29. MOSFET

Turn-on Switching Waveforms & definition of t_r





Boost Switching Definitions

figure 30. FWD

Turn-off Switching Waveforms & definition of t_{tr}

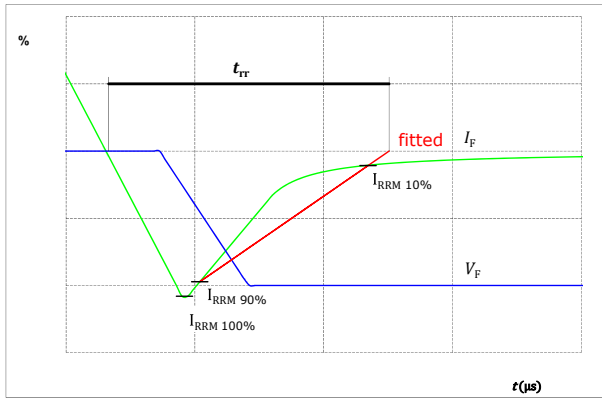


figure 31. FWD

Turn-on Switching Waveforms & definition of t_{Qr} (t_{Qr} = integrating time for Q_r)

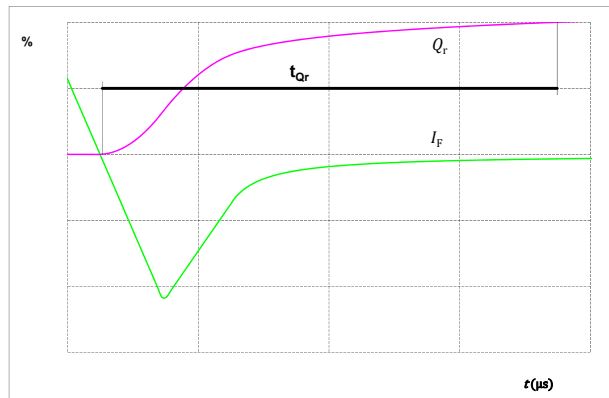
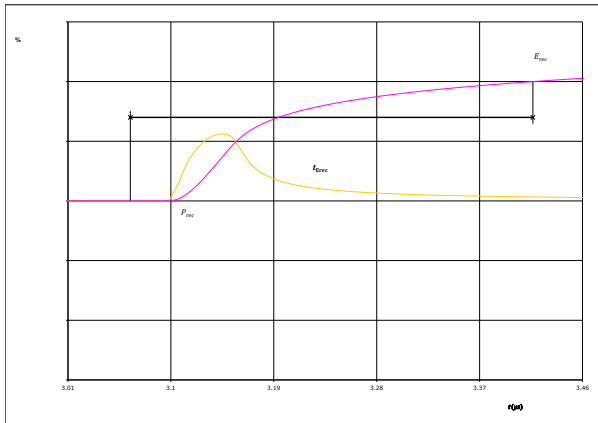


figure 32. FWD

Turn-on Switching Waveforms & definition of t_{Erec} (t_{Erec} = integrating time for E_{rec})





Vincotech

10-PZ12B2A075ME-P621L18Y
datasheet

Ordering Code	
Version	Ordering Code
Without thermal paste	10-PZ12B2A075ME-P621L18Y
With thermal paste (5,2 W/mK, PTM6000HV)	10-PZ12B2A075ME-P621L18Y-/7/
With thermal paste (3,4 W/mK, PSX-P7)	10-PZ12B2A075ME-P621L18Y-/3/

Marking						
	Text	Name	Date code	UL & VIN	Lot	Serial
		NN-NNNNNNNNNNNNNN- TTTTIV	WWYY	UL VIN	LLLLL	SSSS
	Datamatrix	Type&Ver	Lot number	Serial	Date code	
		TTTTTIV	LLLLL	SSSS	WWYY	

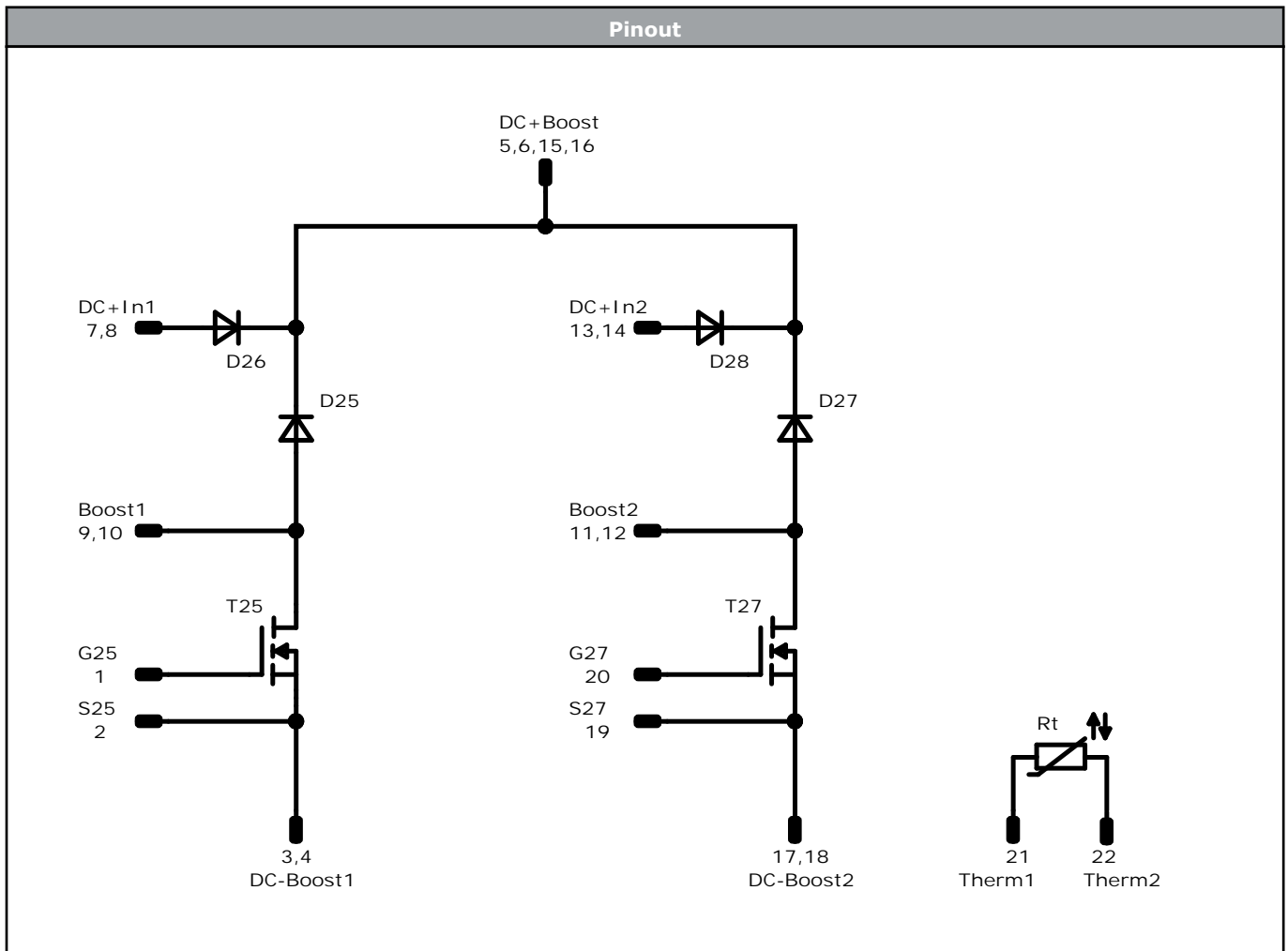
Pin table [mm]				Outline
Pin	X	Y	Function	
1	0	22,5	G25	
2	2,9	22,5	S25	
3	8,3	22,5	DC-Boost1	
4	10,8	22,5	DC-Boost1	
5	19,6	22,5	DC+Boost	
6	22,1	22,5	DC+Boost	
7	29,1	22,5	DC+In1	
8	32	22,5	DC+In1	
9	33,5	17,8	Boost1	
10	33,5	15,3	Boost1	
11	33,5	7,2	Boost2	
12	33,5	4,7	Boost2	
13	32	0	DC+In2	
14	29,1	0	DC+In2	
15	22,1	0	DC+Boost	
16	19,6	0	DC+Boost	
17	10,8	0	DC-Boost2	
18	8,3	0	DC-Boost2	
19	2,9	0	S27	
20	0	0	G27	
21	0	8	Therm1	
22	0	14,5	Therm2	

center of press-fit pinhead
for connection parameter see the handling instruction

Tolerance of pinpositions: ±0,5mm at the end of pins
Dimension of coordinate axis is only offset without tolerance



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Identification					
ID	Component	Voltage	Current	Function	Comment
T25, T27	MOSFET	1200 V	75 mΩ	Boost Switch	
D25, D27	FWD	1200 V	10 A	Boost Diode	
D26, D28	Rectifier	1600 V	28 A	ByPass Diode	
Rt	Thermistor			Thermistor	




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Packaging instruction				
Standard packaging quantity (SPQ) 135	>SPQ	Standard	<SPQ	Sample

Handling instruction
Handling instructions for <i>flow 0</i> packages see vincotech.com website.

Package data
Package data for <i>flow 0</i> packages see vincotech.com website.

Vincotech thermistor reference
See Vincotech thermistor reference table at vincotech.com website.

UL recognition and file number
This device is certified according to UL 1557 standard, UL file number E192116. For more information see vincotech.com website. 

Document No.:	Date:	Modification:	Pages
10-PZ12B2A075ME-P621L18Y-D2-14	5 May. 2022	-/7/ ordering option added New Datasheet format, module is unchanged	

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.